

TC74VHC573F, TC74VHC573FW, TC74VHC573FT, TC74VHC573FK**Octal D-Type Latch with 3-State Output**

The TC74VHC573 is an advanced high speed CMOS OCTAL LATCH with 3-STATE OUTPUT fabricated with silicon gate C2MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

This 8-bit D-type latch is controlled by a latch enable input (LE) and a output enable input (\overline{OE}).

When the \overline{OE} input is high, the eight outputs are in a high impedance state.

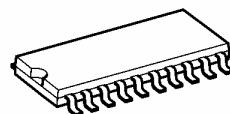
An input protection circuit ensures that 0 to 5.5 V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5 V to 3 V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

Features

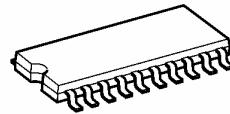
- High speed: $t_{pd} = 4.5$ ns (typ.) at $V_{CC} = 5$ V
- Low power dissipation: $I_{CC} = 4 \mu A$ (max) at $T_a = 25^\circ C$
- High noise immunity: $V_{NIH} = V_{NIL} = 28\% V_{CC}$ (min)
- Power down protection is provided on all inputs.
- Balanced propagation delays: $t_{PLH} \approx t_{PHL}$
- Wide operating voltage range: $V_{CC} (\text{opr}) = 2$ to 5.5 V
- Low noise: $V_{OLP} = 1.2$ V (max)
- Pin and function compatible with 74ALS573

Note: xxxFW (JEDEC SOP) is not available in Japan.

TC74VHC573F

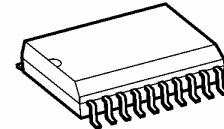


SOP20-P-300-1.27A



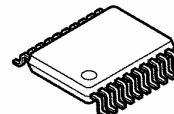
SOP20-P-300-1.27

TC74VHC573FW



SOL20-P-300-1.27

TC74VHC573FT



TSSOP20-P-0044-0.65A

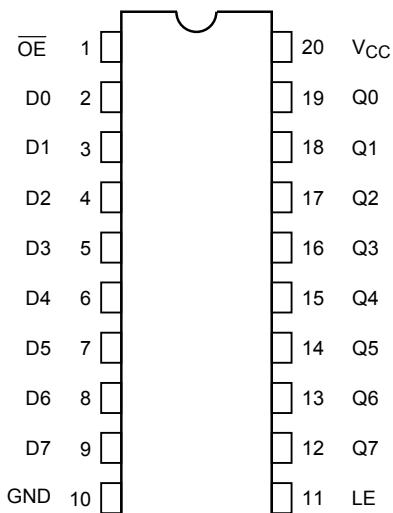
TC74VHC573FK



VSSOP20-P-0030-0.50

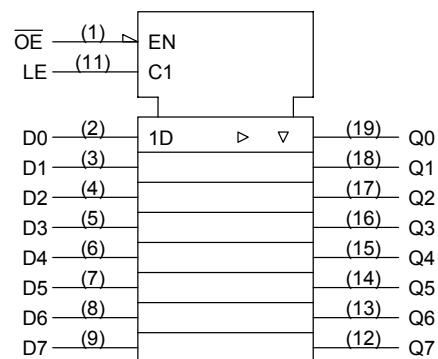
Weight	
SOP20-P-300-1.27A	: 0.22 g (typ.)
SOP20-P-300-1.27	: 0.22 g (typ.)
SOL20-P-300-1.27	: 0.46 g (typ.)
TSSOP20-P-0044-0.65A	: 0.08 g (typ.)
VSSOP20-P-0030-0.50	: 0.03 g (typ.)

Pin Assignment



(top view)

IEC Logic Symbol



Truth Table

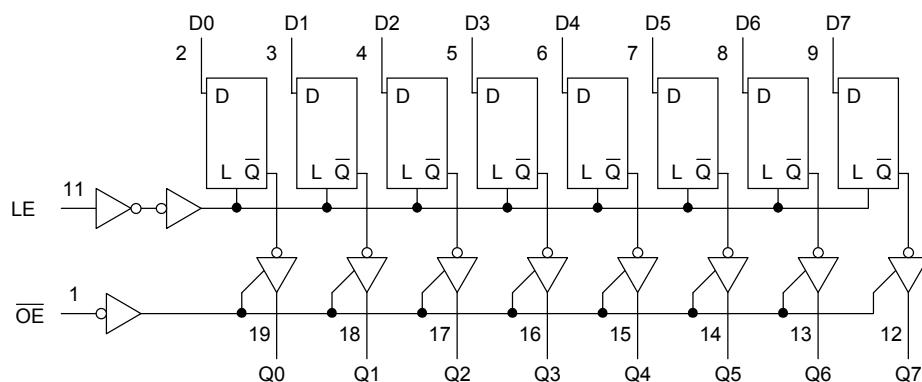
Inputs			Output
\overline{OE}	LE	D	Z
H	X	X	Z
L	L	X	Q _n
L	H	L	L
L	H	H	H

X: Don't care

Z: High impedance

Q_n: Q outputs are latched at the time when the LE input is taken to a low logic level.

System Diagram



Absolute Maximum Ratings (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage range	V _{CC}	-0.5 to 7.0	V
DC input voltage	V _{IN}	-0.5 to 7.0	V
DC output voltage	V _{OUT}	-0.5 to V _{CC} + 0.5	V
Input diode current	I _{IK}	-20	mA
Output diode current	I _{OK}	±20	mA
DC output current	I _{OUT}	±25	mA
DC V _{CC} /ground current	I _{CC}	±75	mA
Power dissipation	P _D	180	mW
Storage temperature	T _{stg}	-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Recommended Operating Conditions (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage	V _{CC}	2.0 to 5.5	V
Input voltage	V _{IN}	0 to 5.5	V
Output voltage	V _{OUT}	0 to V _{CC}	V
Operating temperature	T _{opr}	-40 to 85	°C
Input rise and fall time	d _t /d _v	0 to 100 (V _{CC} = 3.3 ± 0.3 V) 0 to 20 (V _{CC} = 5 ± 0.5 V)	ns/V

Note: The recommended operating conditions are required to ensure the normal operation of the device.
Unused inputs must be tied to either VCC or GND.

Electrical Characteristics**DC Characteristics**

Characteristics	Symbol	Test Condition		Ta = 25°C			Ta = -40 to 85°C		Unit	
				V _{CC} (V)	Min	Typ.	Max	Min		
High-level input voltage	V _{IH}	—		2.0	1.50	—	—	1.50	V	
				3.0 to 5.5	V _{CC} × 0.7	—	—	V _{CC} × 0.7		
Low-level input voltage	V _{IL}	—		2.0	—	—	0.50	—	V	
				3.0 to 5.5	V _{CC} × 0.3	—	V _{CC} × 0.3	—		
High-level output voltage	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -50 µA	2.0	1.9	2.0	—	1.9	V	
				3.0	2.9	3.0	—	2.9		
			I _{OH} = -4 mA	4.5	4.4	4.5	—	4.4		
				3.0	2.58	—	—	2.48		
Low-level output voltage	V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 50 µA	4.5	3.94	—	—	3.80	V	
				2.0	—	0.0	0.1	—		
			I _{OL} = 4 mA	3.0	—	0.0	0.1	—		
				4.5	—	0.0	0.1	—		
3-state output off-state current	I _{OZ}	V _{IN} = V _{IH} or V _{IL} V _{OUT} = V _{CC} or GND		5.5	—	—	±0.25	—	±2.50 µA	
Input leakage current	I _{IN}	V _{IN} = 5.5 V or GND		0 to 5.5	—	—	±0.1	—	±1.0 µA	
Quiescent supply current	I _{CC}	V _{IN} = V _{CC} or GND		5.5	—	—	4.0	—	40.0 µA	

Timing Requirements (input: t_r = t_f = 3 ns)

Characteristics	Symbol	Test Condition		Ta = 25°C		Ta = -40 to 85°C		Unit
				V _{CC} (V)	Typ.	Limit	Limit	
Minimum pulse width (LE)	t _w (H)	—		3.3 ± 0.3	—	5.0	5.0	ns
				5.0 ± 0.5	—	5.0	5.0	
Minimum set-up time	t _s	—		3.3 ± 0.3	—	3.5	3.5	ns
				5.0 ± 0.5	—	3.5	3.5	
Minimum hold time	t _h	—		3.3 ± 0.3	—	1.5	1.5	ns
				5.0 ± 0.5	—	1.5	1.5	

AC Characteristics (input: $t_r = t_f = 3 \text{ ns}$)

Characteristics	Symbol		Test Condition		Ta = 25°C			Ta = -40 to 85°C		Unit	
			V _{CC} (V)	C _L (pF)	Min	Typ.	Max	Min	Max		
Propagation delay time (LE-Q)	t _{pLH}	—	3.3 ± 0.3	15	—	7.6	11.9	1.0	14.0	ns	
				50	—	10.1	15.4	1.0	17.5		
	t _{pHL}		5.0 ± 0.5	15	—	5.0	7.7	1.0	9.0		
				50	—	6.5	9.7	1.0	11.0		
	t _{pLH}	—	3.3 ± 0.3	15	—	7.0	11.0	1.0	13.0	ns	
				50	—	9.5	14.5	1.0	16.5		
	t _{pHL}		5.0 ± 0.5	15	—	4.5	6.8	1.0	8.0		
				50	—	6.0	8.8	1.0	10.0		
3-state output enable time	t _{pZL}	R _L = 1 kΩ	3.3 ± 0.3	15	—	7.3	11.5	1.0	13.5	ns	
				50	—	9.8	15.0	1.0	17.0		
	t _{pZH}		5.0 ± 0.5	15	—	5.2	7.7	1.0	9.0		
				50	—	6.7	9.7	1.0	11.0		
	t _{pLZ}	R _L = 1 kΩ	3.3 ± 0.3	50	—	10.7	14.5	1.0	16.5	ns	
			5.0 ± 0.5	50	—	6.7	9.7	1.0	11.0		
	t _{osLH}	(Note 1)	3.3 ± 0.3	50	—	—	1.5	—	1.5	ns	
			5.0 ± 0.5	50	—	—	1.0	—	1.0		
Input capacitance	C _{IN}		—		—	4	10	—	10	pF	
Output capacitance	C _{OUT}		—		—	6	—	—	—	pF	
Power dissipation capacitance	C _{PD}			(Note 2)	—	29	—	—	—	pF	

Note 1: Parameter guaranteed by design.

$$t_{osLH} = |t_{pLHm} - t_{pLHn}|, t_{osHL} = |t_{pHLm} - t_{pHLn}|$$

Note 2: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC (\text{opr})} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 \text{ (per latch)}$$

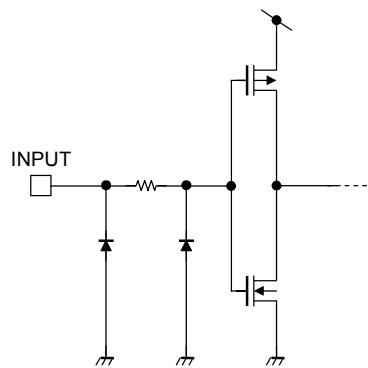
And the total C_{PD} when n pcs. of latch operate can be gained by the following equation:

$$C_{PD} (\text{total}) = 21 + 8 \cdot n$$

Noise Characteristics (input: $t_r = t_f = 3 \text{ ns}$) (Note)

Characteristics	Symbol	Test Condition	$V_{CC} (\text{V})$	$T_a = 25^\circ\text{C}$		Unit
				Typ.	Max	
Quiet output maximum dynamic V_{OL}	V_{OLP}	$C_L = 50 \text{ pF}$	5.0	0.8 (0.9)	1.0 (1.2)	V
Quiet output minimum dynamic V_{OL}	V_{OLV}	$C_L = 50 \text{ pF}$	5.0	-0.8 (-0.9)	-1.0 (-1.2)	V
Minimum high level dynamic input voltage	V_{IHD}	$C_L = 50 \text{ pF}$	5.0	—	3.5	V
Maximum low level dynamic input voltage	V_{ILD}	$C_L = 50 \text{ pF}$	5.0	—	1.5	V

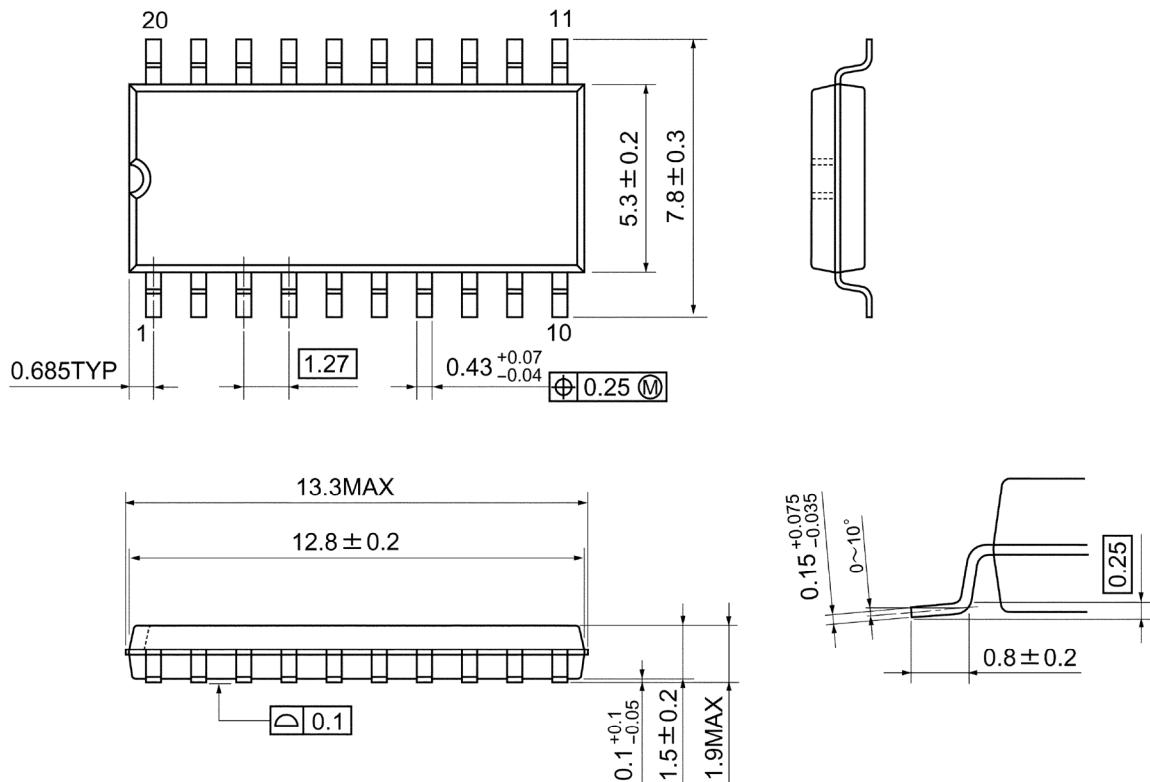
Note: The value in () only applies to JEDEC SOP (FW) devices.

Input Equivalent Circuit

Package Dimensions

SOP20-P-300-1.27A

Unit: mm

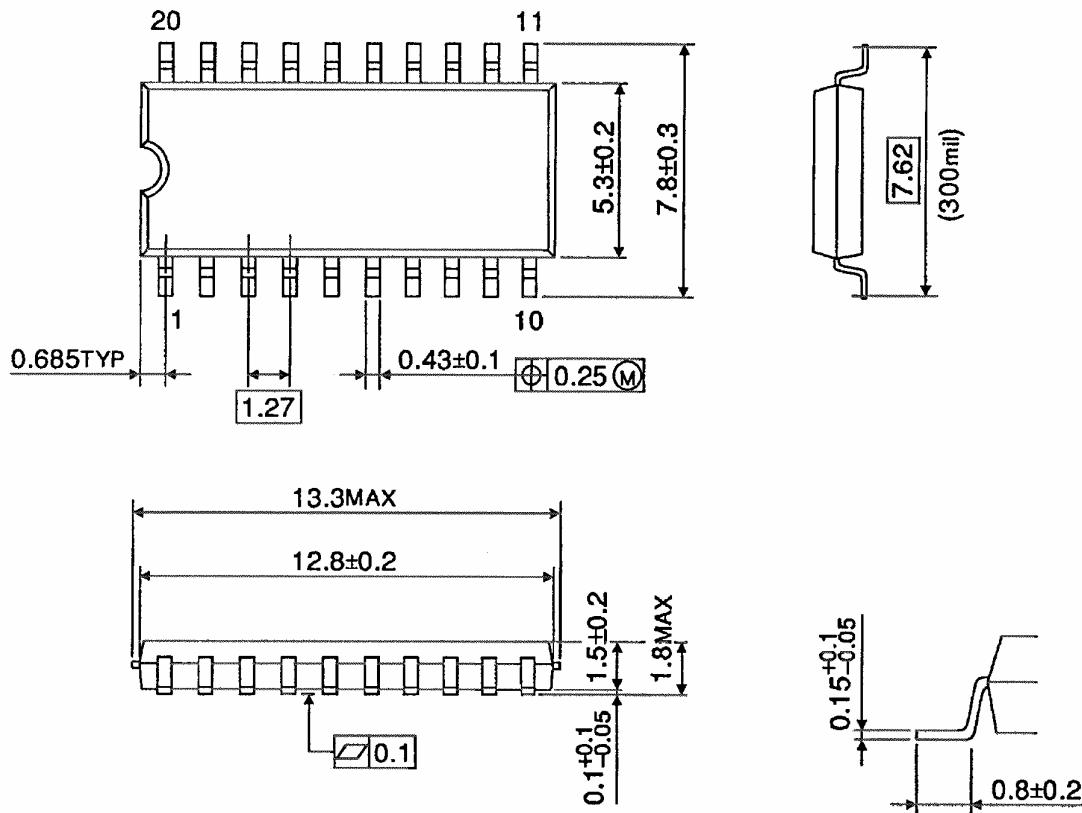


Weight: 0.22 g (typ.)

Package Dimensions

SOP20-P-300-1.27

Unit : mm

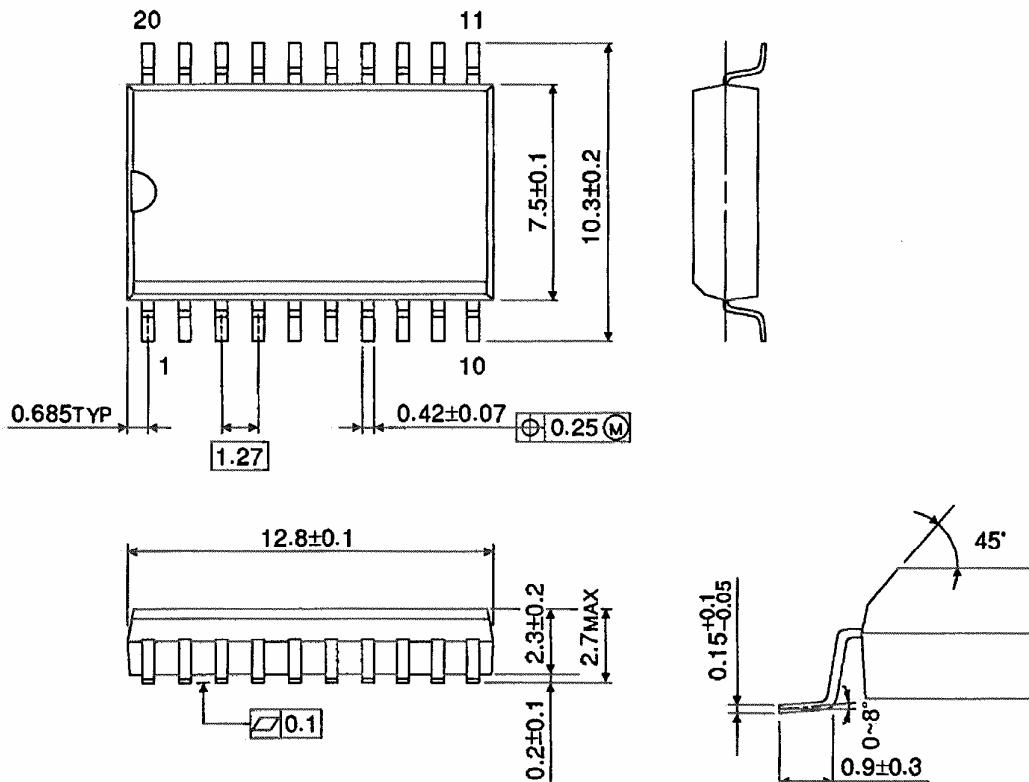


Weight: 0.22 g (typ.)

Package Dimensions (Note)

SOL20-P-300-1.27

Unit : mm



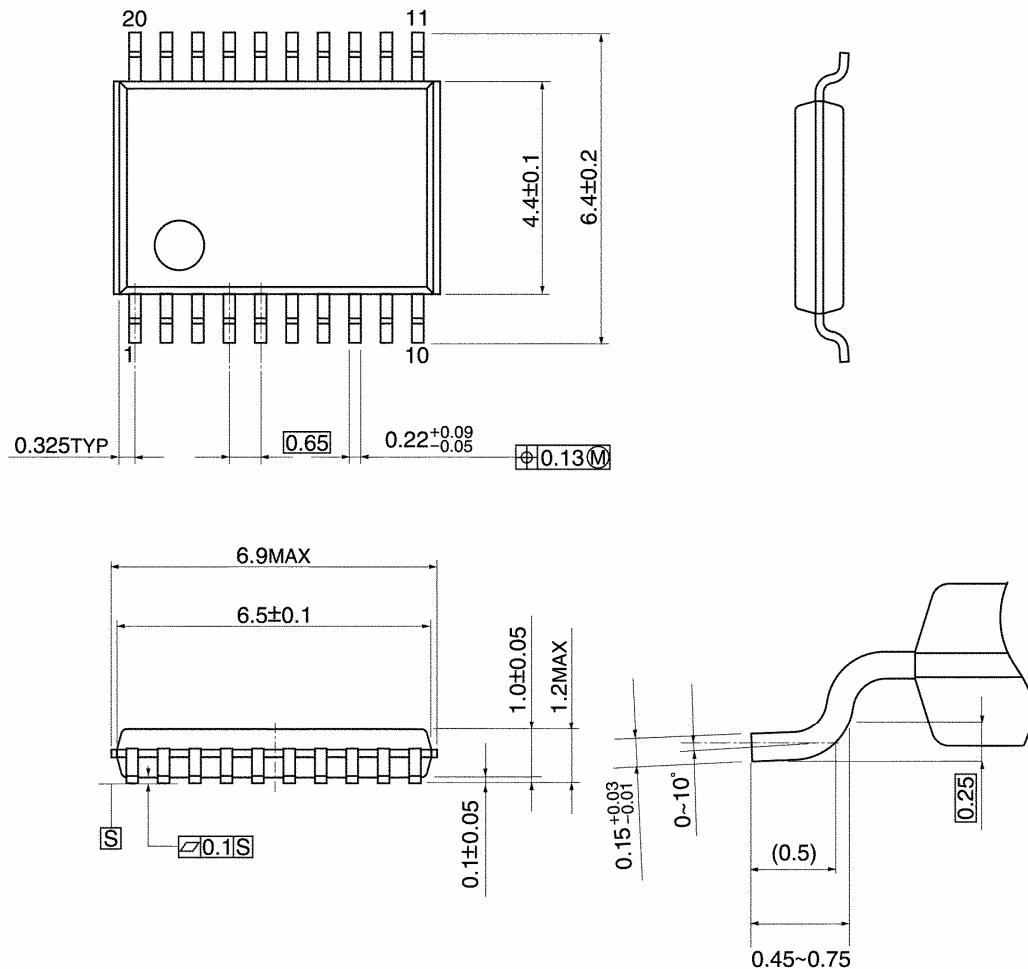
Note: This package is not available in Japan.

Weight: 0.46 g (typ.)

Package Dimensions

TSSOP20-P-0044-0.65A

Unit: mm

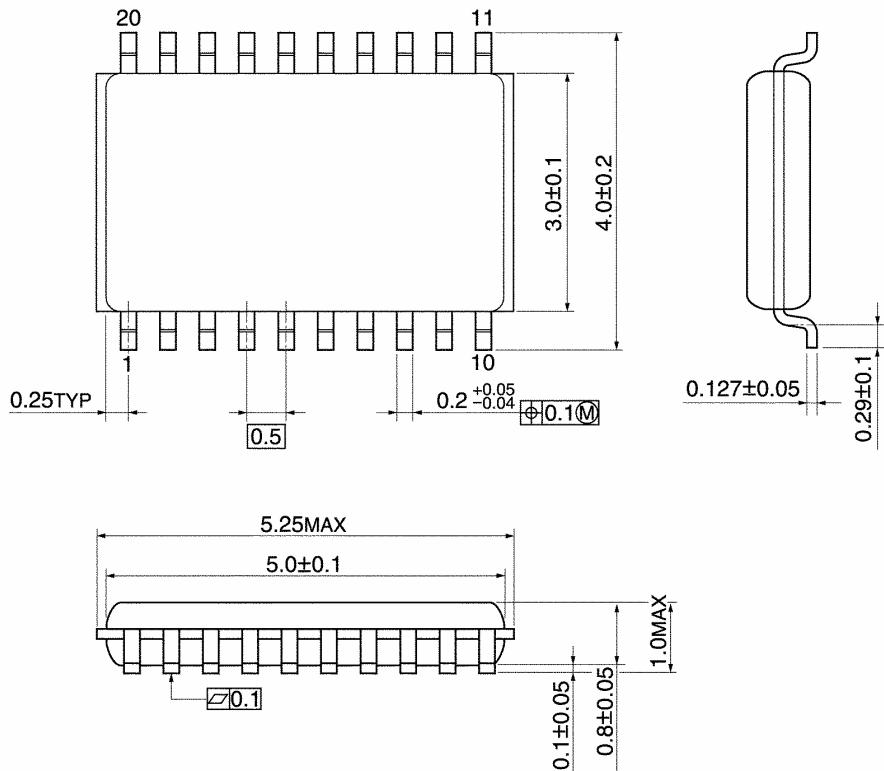


Weight: 0.08 g (typ.)

Package Dimensions

VSSOP20-P-0030-0.50

Unit: mm



Weight: 0.03 g (typ.)

Note: Lead (Pb)-Free Packages**SOP20-P-300-1.27A TSSOP20-P-0044-0.65A VSSOP20-P-0030-0.50****RESTRICTIONS ON PRODUCT USE**

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